

Irish Standard I.S. EN 60749-13:2002

Semiconductor devices - Mechanical and climatic test methods - Part 13: Salt atmosphere

© CENELEC 2015 No copying without NSAI permission except as permitted by copyright law.

I.S. EN 60749-13:2002

Incorporating amendments/corrigenda/National Annexes issued since publication:

The National Standards Authority of Ireland (NSAI) produces the following categories of formal documents:

I.S. xxx: Irish Standard — national specification based on the consensus of an expert panel and subject to public consultation.

S.R.~xxx: Standard~Recommendation-recommendation~based~on~the~consensus~of~an~expert~panel~and~subject~to~public~consultation.

SWiFT xxx: A rapidly developed recommendatory document based on the consensus of the participants of an NSAI workshop.

This document replaces/revises/consolidates the NSAI adoption of the document(s) indicated on the CEN/CENELEC cover/Foreword and the following National document(s):

NOTE: The date of any NSAI previous adoption may not match the date of its original CEN/CENELEC document.

This document is based on:

Published:

EN 60749-13:2002

2002-08-16

This document was published under the authority of the NSAI and comes into effect on:

ICS number:

2015-02-19

NOTE: If blank see CEN/CENELEC cover page

Sales:

NSAI T +353 1 807 3800

 1 Swift Square,
 F +353 1 807 3838
 T +353 1 857 6730

 Northwood, Santry
 E standards@nsai.ie
 F +353 1 857 6729

 Dublin 9
 W NSAI.ie
 W standards.ie

Údarás um Chaighdeáin Náisiúnta na hÉireann

EUROPEAN STANDARD

EN 60749-13

NORME EUROPÉENNE

EUROPÄISCHE NORM

August 2002

ICS 31.080.01

Partly supersedes EN 60749:1999 + A1:2000 + A2:2001

English version

Semiconductor devices Mechanical and climatic test methods Part 13: Salt atmosphere

(IEC 60749-13:2002)

Dispositifs à semiconducteurs -Méthodes d'essais mécaniques et climatiques Partie 13: Atmosphère saline (CEI 60749-13:2002) Halbleiterbauelemente -Mechanische und klimatische Prüfverfahren Teil 13: Salzatmosphäre (IEC 60749-13:2002)

This European Standard was approved by CENELEC on 2002-07-02. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Czech Republic, Denmark, Finland, France, Germany, Greece, Hungary, Iceland, Ireland, Italy, Luxembourg, Malta, Netherlands, Norway, Portugal, Slovakia, Spain, Sweden, Switzerland and United Kingdom.

CENELEC

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

EN 60749-13:2002

- 2 -

Foreword

The text of document 47/1599/FDIS, future edition 1 of IEC 60749-13, prepared by IEC TC 47, Semiconductor devices, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 60749-13 on 2002-07-02.

This mechanical and climatic test method, as it relates to salt atmosphere, is a complete rewrite of the test contained in clause 6, chapter 3 of EN 60749:1999.

The following dates were fixed:

 latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement

(dop) 2003-04-01

 latest date by which the national standards conflicting with the EN have to be withdrawn

(dow) 2005-07-01

Annexes designated "normative" are part of the body of the standard. In this standard, annex ZA is normative.

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 60749-13:2002 was approved by CENELEC as a European Standard without any modification.

EN 60749-13:2002

Annex ZA (normative)

Normative references to international publications with their corresponding European publications

This European Standard incorporates by dated or undated reference, provisions from other publications. These normative references are cited at the appropriate places in the text and the publications are listed hereafter. For dated references, subsequent amendments to or revisions of any of these publications apply to this European Standard only when incorporated in it by amendment or revision. For undated references the latest edition of the publication referred to applies (including amendments).

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

| <u>Publication</u> | <u>Year</u> | <u>Title</u> | EN/HD | <u>Year</u> |
|--------------------|-------------|--|---------------|-------------|
| IEC 60749-14 | _ 1) | Semiconductor devices - Mechanical and climatic test methods Part 14: Robustness of terminaisons (lead integrity) | - | - |
| IEC 60068-2-11 | 1981 | Environmental testing Part 2: Tests - Test Ka: Salt mist | EN 60068-2-11 | 1999 |

-

¹⁾ To be published.

This is a free page sample. Access the full version online.

This page is intentionally left blank



| | This is a free preview. | Purchase the e | entire publication | at the link below: |
|--|-------------------------|----------------|--------------------|--------------------|
|--|-------------------------|----------------|--------------------|--------------------|

Product Page

- Dooking for additional Standards? Visit Intertek Inform Infostore
- Dearn about LexConnect, All Jurisdictions, Standards referenced in Australian legislation